

Notice of References Cited	Application/Control No. 10/553,846	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Tuyet Vo	Art Unit 2821	Page 1 of 1

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*	A	US-2003/0034744	02-2003	Toyama, Koichi	315/291
*	B	US-2004/0113567	06-2004	Yamauchi et al.	315/291
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NON-PATENT DOCUMENTS

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